

Search Notes

Application/Control No.

10/774,607

Examiner

Tuan A. Tran

Applicant(s)/Patent under
Reexamination

NAKAI, SHINYA

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	78-83	11/10/2006	TT
455	73,550.1		
455	552.1		
455	553.1		
455	575.1,7		
455	90.1-3		
333	100-104		
333	134,175		
370	275,278		
370	290-291		
370	286,297		
370	246,172		
370	185		
257	728,760		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, USPGPUB, USOCR, FPRS, JPO, EPO, DERWENT)	11/10/2006	TT
EAST (USPAT, USPGPUB, USOCR, FPRS, JPO, EPO, DERWENT) Updating search	12/12/2006	TT
Consulted with Cong Le	12/12/2006	TT

Search Notes (continued)

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SEARCHED

Class	Subclass	Date	Examiner
257	664,347	11/10/2006	TT
343	700MS		
343	700R		
343	701-702		
Updating Search (12/12/06) as			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, USPGPUB, USOCR, FPRS, JPO, EPO, DERWENT)	11/10/2006	TT
EAST (USPAT, USPGPUB, USOCR, FPRS, JPO, EPO, DERWENT)	12/12/2006	TT